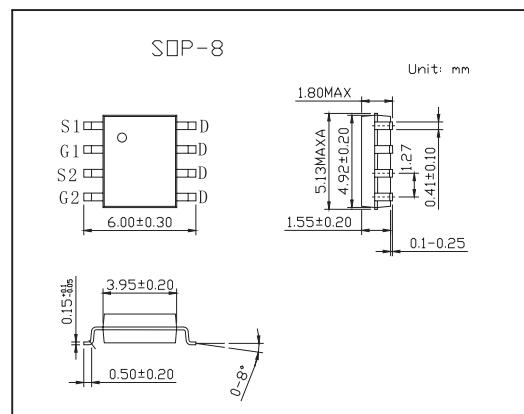
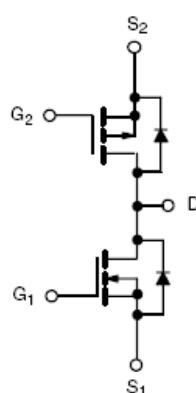


## Complementary (N- and P-Channel) MOSFET Half-Bridge

### KI4501ADY

#### ■ Features

- TrenchFET Power MOSFET



#### ■ Absolute Maximum Ratings TA = 25°C

Parameter	Symbol	N-Channel		P-Channel		Unit
		10 sec	Steady State	10 sec	Steady State	
Drain-Source Voltage	V <sub>DS</sub>		30		-8	V
Gate-Source Voltage	V <sub>GS</sub>		±20		±8	V
Continuous Drain Current (T <sub>J</sub> = 150°C)*	I <sub>D</sub>	8.8	6.3	-5.7	-4.1	A
T <sub>A</sub> = 70°C		7	5.2	-4.5	-3.3	A
Pulsed Drain Current	I <sub>DM</sub>		30		-30	A
Continuous Source Current (Diode Conduction)*	I <sub>S</sub>	1.8	1	-1.8	1	A
Maximum Power Dissipation*	P <sub>D</sub>	2.5	1.3	2.5	1.3	W
T <sub>A</sub> = 70°C		1.6	0.84	1.6	0.84	W
Operating Junction and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	-55 to 150				°C

\*Surface Mounted on FR4 Board; t ≤ 10 sec.

#### ■ Thermal Resistance Ratings TA = 25°C

Parameter	Symbol	N-Channel		P-Channel		Unit
		Typ	Max	Typ	Max	
Maximum Junction-to-Ambient*	R <sub>thJA</sub>	40	50	42	50	°C/W
		75	95	76	95	
Maximum Junction-to-Foot	R <sub>thJc</sub>	18	23	21	26	

\*Surface Mounted on FR4 Board.

## KI4501ADY

■ Electrical Characteristics Ta = 25°C

Parameter	Symbol	Testconditons		Min	Typ	Max	Unit	
Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250 μ A	N-Ch	0.8		1.8	V	
		V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = -250 μ A	P-Ch	-0.45		1.0		
Gate Body Leakage	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V V <sub>GS</sub> = ±20 V	N-Ch			±100	nA	
		V <sub>DS</sub> = 0 V V <sub>GS</sub> = ±8 V	P-Ch			±100		
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 30V, V <sub>GS</sub> = 0 V	N-Ch			1	μ A	
		V <sub>DS</sub> = -8V, V <sub>GS</sub> = 0 V	P-Ch			-1		
		V <sub>DS</sub> = 30 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55°C	N-Ch			5		
		V <sub>DS</sub> = -8V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55°C	P-Ch			-5		
On State Drain Currenta	I <sub>D(on)</sub>	V <sub>DS</sub> = 5 V, V <sub>GS</sub> = 10 V	N-Ch	30			A	
		V <sub>DS</sub> = -5 V, V <sub>GS</sub> = -4.5 V	P-Ch	-20				
Drain Source On State Resistance*	r <sub>D(on)</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 8.8A	N-Ch		0.015	0.018	Ω	
		V <sub>GS</sub> = -4.5 V, I <sub>D</sub> = -5.7A	P-Ch		0.030	0.042		
		V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 7.0A	N-Ch		0.022	0.027		
		V <sub>GS</sub> = -2.5 V, I <sub>D</sub> = -4.8A	P-Ch		0.048	0.060		
Forward Transconductance*	g <sub>fs</sub>	V <sub>DS</sub> = 15 V, I <sub>D</sub> = 8.8A	N-Ch		18		S	
		V <sub>DS</sub> = -15 V, I <sub>D</sub> = -5.7A	P-Ch		12			
Diode Forward Voltage*	V <sub>SD</sub>	I <sub>S</sub> = 1.8A, V <sub>GS</sub> = 0 V	N-Ch		0.73	1.1	V	
		I <sub>S</sub> = -1.8A, V <sub>GS</sub> = 0 V	P-Ch		-0.75	- 1.1		
Total Gate Charge	Q <sub>g</sub>	N-Channel V <sub>DS</sub> = 15 V, V <sub>GS</sub> = 5V, I <sub>D</sub> = 8.8A	N-Ch		11.5	20	nC	
Gate Source Charge	Q <sub>gs</sub>		P-Ch		13.5	20		
Gate Drain Charge	Q <sub>gd</sub>		N-Ch		3			
Turn On Time	t <sub>d(on)</sub>		P-Ch		2.2			
	P-Channel V <sub>DD</sub> = -4 V, R <sub>L</sub> = 4 Ω I <sub>D</sub> = -1 A, V <sub>GEN</sub> = -4.5 V, R <sub>g</sub> = 6 Ω	N-Ch		40		ns		
Rise Time		t <sub>r</sub>	P-Ch		15			
Turn Off Delay Time		t <sub>d(off)</sub>		N-Ch			8	15
				P-Ch			45	70
Fall Time	t <sub>f</sub>	N-Ch V <sub>DD</sub> = 15 V, R <sub>L</sub> = 15 Ω I <sub>D</sub> = 1 A, V <sub>GEN</sub> = 10V, R <sub>g</sub> = 6 Ω	N-Ch		35	50		
Source-Drain Reverse Recovery Time	t <sub>rr</sub>		P-Ch		60	100		
		P-Channel V <sub>DD</sub> = -4 V, R <sub>L</sub> = 4 Ω I <sub>D</sub> = -1 A, V <sub>GEN</sub> = -4.5 V, R <sub>g</sub> = 6 Ω	N-Ch		10	20		
			P-Ch		55	85		
		I <sub>F</sub> = 1.8 A, di/dt = 100 A/μ s	N-Ch		30	60		
			P-Ch		50	100		

\* Pulse test; pulse width ≤300 μ s, duty cycle≤2%.